

**Search Notes**

Application/Control No.

10/795,817

Examiner

Sam K. Ahn

Applicant(s)/Patent under  
Reexamination

VENKATESH ET AL

Art Unit

2611

**SEARCHED**

Class	Subclass	Date	Examiner
375	140,142,1 43,145,14 9,150,152, 343	4/10/2007	SA
370	390.62,507		
455	265		
702	89		
713	345,400	4/11/2007	SA

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST, inventor search, keyword and citation search IEEE and google, keyword and citation search	4/11/2007	SA